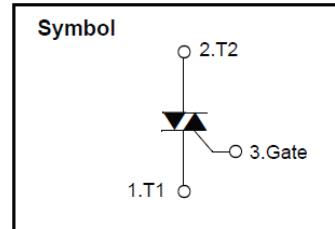


Sensitive Gate Triac
Features

- ◆ Repetitive Peak Off-State Voltage : 600V
- ◆ R.M.S On-State Current ($I_{T(RMS)} = 4 \text{ A}$)
- ◆ Low On-State Voltage (1.6V(Typ.) @ I_{TM})
- ◆ High Commutation dv/dt
- ◆ Sensitive Gate Triggering 4 Mode


General Description

Sensitive gate triggering Triac is suitable for direct coupling to TTL, HTL, CMOS and application such as various logic functions, low power AC switching applications, such as fan speed, small light controllers and home appliance equipment.

Absolute Maximum Ratings ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Param	Conditi	Ratings	Units
V_{DRM}	Repetitive Peak Off-State Voltage		600	V
$I_{T(RMS)}$	R.M.S On-State Current	$T_C = 109^\circ\text{C}$	4.0	A
I_{TSM}	Surge On-State Current	One Cycle, 50Hz/60Hz, Peak, Non-Repetitive	30/33	A
I^2t	I^2t		4.5	A^2s
P_{GM}	Peak Gate Power Dissipation		1.5	W
$P_{G(AV)}$	Average Gate Power Dissipation		0.1	W
I_{GM}	Peak Gate Current		1.0	A
V_{GM}	Peak Gate Voltage		7.0	V
T_J	Operating Junction Temperature		- 40 ~ 125	$^\circ\text{C}$
T_{STG}	Storage Temperature		- 40 ~ 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance Junction to Case(DC)	2.6	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient(DC)	100	$^\circ\text{C}/\text{W}$

STU4A60S

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Items	Conditions	Rating			Unit
			Min.	Typ.	Max.	
I_{DRM}	Repetitive Peak Off-State Current	$V = V_{DRM}$, Single Phase, Half Wave $T_J = 125^\circ\text{C}$	—	—	1.0	mA
V_{TM}	Peak On-State Voltage	$I_T = 6 \text{ A}$, Inst. Measurement	—	—	1.6	V
I^+_{GT1}	I	Gate Trigger Current $V_D = 6 \text{ V}$, $R_L = 10 \Omega$	—	—	5	mA
I^-	II		—	—	5	
I^-	III		—	—	5	
I^+_{GT3}	IV		—	8	12	
V^+_{GT1}	I	Gate Trigger Voltage $V_D = 6 \text{ V}$, $R_L = 10 \Omega$	—	—	1.4	V
V^-_{GT1}	II		—	—	1.4	
V^-_{GT3}	III		—	—	1.4	
V^+_{GT3}	IV		—	1.6	2.0	
V_{GD}	Non-Trigger Gate Voltage	$T_J = 125^\circ\text{C}$, $V_D = 1/2 V_{DRM}$	0.	—	—	V
$(dv/dt)_c$	Critical Rate of Rise Off-State Voltage at Commutation	$T_J = 125^\circ\text{C}$, $[di/dt]_c = -2.0 \text{ A/ms}$, $V_D = 2/3 V_{DRM}$	5	—	—	$\text{V}/\mu\text{s}$
I_H	Holding Current		—	—	10	mA

Fig 1. Gate Characteristics

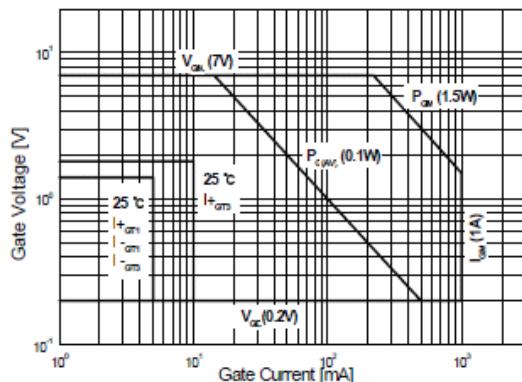


Fig 3. On State Current vs. Maximum Power Dissipation

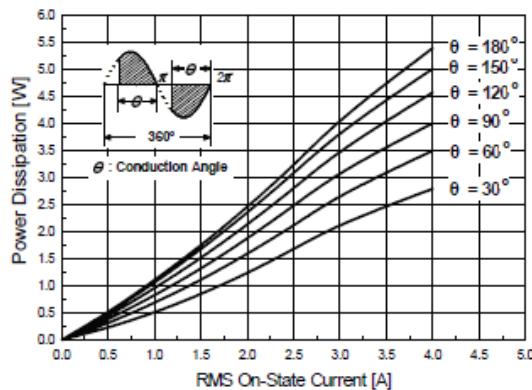


Fig 2. On-State Voltage

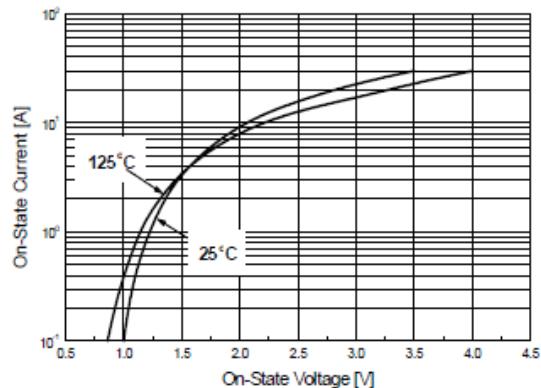


Fig 4. On State Current vs. Allowable Case Temperature

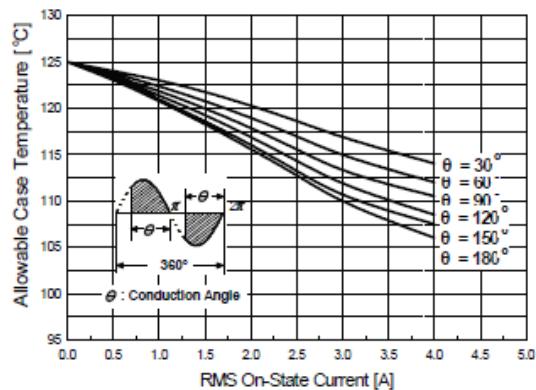


Fig 5. Surge On-State Current Rating (Non-Repetitive)

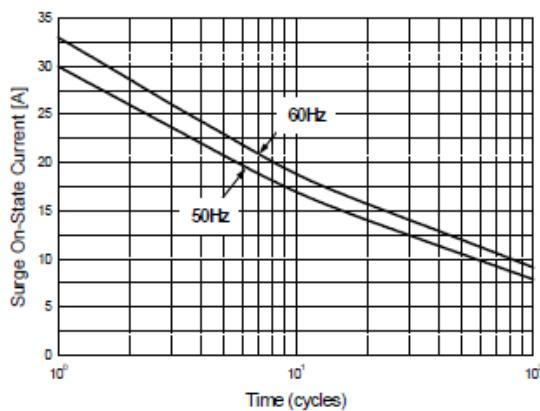


Fig 6. Gate Trigger Voltage vs. Junction Temperature

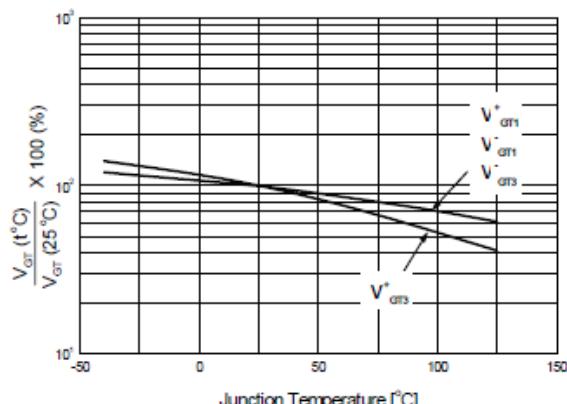


Fig 7. Gate Trigger Current vs. Junction Temperature

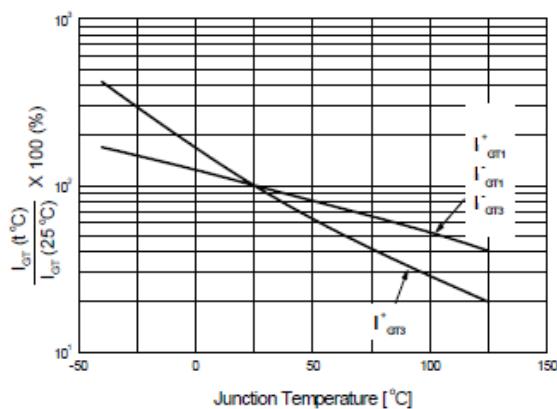


Fig 8. Transient Thermal Impedance

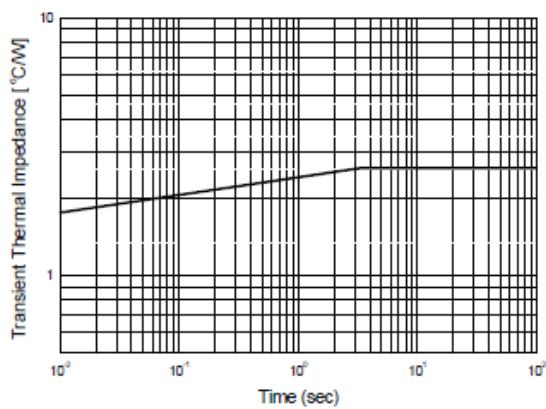
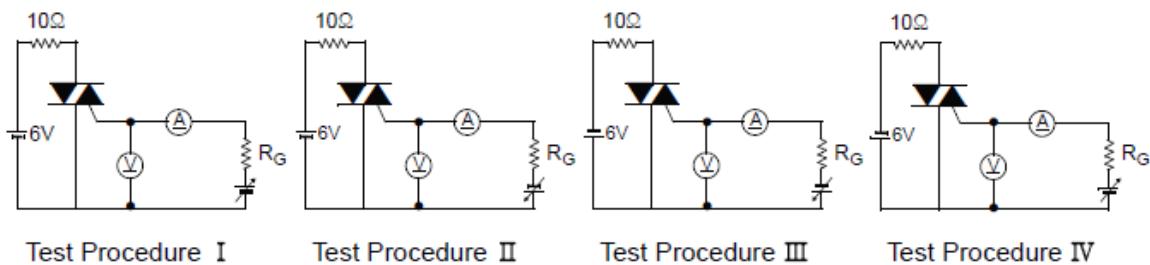


Fig 9. Gate Trigger Characteristics Test Circuit



Test Procedure I

Test Procedure II

Test Procedure III

Test Procedure IV

TO-251 Package Dimension